

# **Notice of References Cited**

Application/Control No.

10/890,835

Applicant(s)/Patent Under  
Reexamination  
KANAGASABATHY ET AL.

Examiner

Sin J. Lee

Art Unit

1752

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## **U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-5,759,755	06-1998	Park et al.	430/512
B	US-			
C	US-			
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

## **FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N	EP 0 814 361 A1	12-1997	EUROPEAN	Kawamura et al.	N/A
O	JP 11-327145	11-1999	JAPAN	Kawabe et al.	N/A
P	JP 2001-201855	07-2001	JAPAN	Mizutani	N/A
Q					
R					
S					
T					

## **NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	DERWENT English abstract for JP 11-327145
V	Machine-Assisted English translation for JP 11-327145 (provided by Japan Patent Office)
W	DERWENT English abstract for JP 2001-201855
X	Machine-Assisted English translation for JP 2001-201855 (provided by Japan Patent Office)

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.02(a).)  
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